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|-----------------------------------|--|-------------------------|---|------------------------------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination 10/572,322 BASTEIN ET AL. | |
| | | Examiner | Art Unit | Page 1 of 1 Thomas Diaz 4171 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | A | US-3,600,970 | 08-1971 | LOOFBOURROW, Alan G. | 74/492 |
| * | B | US-5,669,718 | 09-1997 | Sakairi et al. | 384/220 |
| * | C | US-5,417,614 | 05-1995 | Dykema et al. | 464/162 |
| * | D | US-5,071,163 | 12-1991 | Heinrichs et al. | 280/775 |
| * | E | US-4,479,786 | 10-1984 | De Bisschop, James G. | 464/89 |
| * | F | US-4,310,063 | 01-1982 | Nishikawa, Masao | 180/423 |
| * | G | US-3,877,319 | 04-1975 | Cooper, Duane D. | 74/492 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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